


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578512	<b>Applicant(s)/Patent Under Reexamination</b>  FUNKE ET AL.
	<b>Examiner</b>  John Pak	<b>Art Unit</b>  1616

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
514	341, 462	5/10	JP

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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